

General Purpose Type  
for  
Low Power Applications

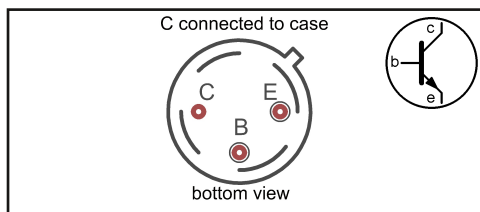
Features:

- High temperature characterization
- High dc-beta at 200mA
- Full switching-time characterization at 200mA

The 2N1700 is a hometaxial-base, silicon n-p-n power transistor intended for a wide variety of applications in industrial and military equipment. The device is particularly useful in power-switching circuits such as in dc-to-dc converters, choppers, solenoid and relay controls; in oscillator, regulator, and pulse amplifier circuits; and as class A and class B push-pull audio and servo amplifiers.

The 2N1700 is supplied in the JEDEC TO-39 hermetic package.

**Terminal Designations**



**JEDEC TO-39**

**MAXIMUM RATINGS, Absolute-Maximum Values:**

$V_{CBO}$	<b>60</b>	V
$V_{CEV}^{(SUS)}$ ( $V_{EB} = 1.5\text{Volts}$ )	<b>60</b>	V
$V_{CEO}^{(SUS)}$	<b>40</b>	V
$V_{EBO}$	<b>6</b>	V
$I_C$	<b>1</b>	A
$I_B$	<b>0.75</b>	A
$P_T$ at case temperature of 25°C	<b>5</b>	W
$T_{stg} T_J$	<b>-65 to +200</b>	°C
$T_L$ At distance $\geq 1/32$ in. (0.8mm) from seating plane for 10s max.	<b>255</b>	°C

Electrical Characteristics, at Case Temp. ( $T_C$ ) = 25°C unless otherwise specified

SYMBOL	TEST CONDITIONS						LIMITS		UNITS
	VOLTAGE V dc			CURRENT mA dc					
	$V_{CB}$	$V_{CE}$	$V_{EB}$	$I_C$	$I_B$	$I_E$	Min	Max	
$I_{CBO}$ $T_C=150^\circ\text{C}$	30					0	-	75	$\mu\text{A}$
	30					0	-	1000	
$I_{EBO}$			6	0			-	25	$\mu\text{A}$
$V_{CEV}$			1.5	0.5			60	-	V
$V_{CEO}^{(SUS)}$				50	0		-	-	
$V_{BE}$		4		100			-	2	V
$V_{CE}^{(sat)}$				200	10		-	-	V
$h_{FE}$		4		100			20	80	
$h_{fe}$		4		5			40 Typ.		
$r_{CE}^{(sat)}$				100	10		-	10	$\Omega$
$C_{ob}$	40						150 Typ.		pF
$T_1$							10 Typ.		ms
$f_{ab}$	28			5			1.5 Typ.		MHz
$t_d^\circ$							0.2 Typ.		$\mu\text{s}$
$t_r^\circ$							1 Typ.		
$t_s^\circ$							0.6 Typ.		
$t_f^\circ$							1 Typ.		
$R_{0JC}$							-	35	$^\circ\text{C/W}$
$R_{0JFA}$							-	200	

Note •:  $I_C = 200\text{mA}$ ,  $I_{B1} = 20\text{mA}$ ,  $I_{B2} = -85\text{mA}$

## Terms and Symbols

$C_{ob}$	- common-base output capacitance
$f_T$	- gain-bandwidth product (unity-gain frequency for devices in which gain roll-off has a -1 slope)
$f_{ob}$	- base (alpha) cutoff frequency
$h_{FE}$	- dc forward-current transfer ratio
$h_{fe}$	- common-emitter, small-signal, short-circuit, forward-current transfer ratio
$ h_{fe} $	- magnitude of common-emitter, small-signal, short-circuit, forward-current transfer ratio
$I_C$	- continuous collector current
$I_{CM}$	- peak collector current
$I_{CER}$	- collector-cutoff current with specified resistance between base and emitter
$I_{CEX}$	- collector-cutoff current with specified circuit between base and emitter
$I_B$	- continuous base current
$I_{EBO}$	- emitter-cutoff current, collector open
$I_{CBO}$	- collector-cutoff current, emitter open
$I_{S/b}$	- forward-bias, second break-down collector current
$P_T$	- transistor dissipation at specified temperature
$r_{CE}^{(sat)}$	- dc collector-to-emitter saturation resistance
$R_{BE}$	- external base-to-emitter resistance
$R_{\theta JC}$	- thermal resistance, junction-to-case
$R_{\theta JFA}$	- thermal resistance, junction-to-free air
$t_d$	- delay time
$t_r$	- rise time
$t_f$	- fall time
$T_C$	- case temperature
$T_{stg}$	- storage temperature
$T_J$	- operating (junction) temperature
$T_L$	- lead temperature during soldering
$V_{CBO}$	- collector-to-base voltage, emitter open
$V_{CEO}$	- collector-to-emitter voltage, base open
$V_{CEO}^{(sus)}$	- collector-to-emitter sustaining voltage, base open
$V_{CER}^{(sus)}$	- collector-to-emitter sustaining voltage with specified resistance between base and emitter
$V_{EBO}$	- emitter-to-base voltage, collector open
$V_{BE}$	- base-to-emitter voltage
$V_{CE}^{sat}$	- collector-to-emitter saturation voltage
$T$	- torque
$\theta$	- conduction angle